

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination HANAWA, KEIJI	
		Examiner Barry Choobin	Art Unit 2625	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,410,346	04-1995	Sancyoshi et al.	348/116
	B	US-5,633,705	05-1997	Asayama, Yoshiaki	356/3.14
	C	US-5,670,935	09-1997	Schofield et al.	340/461
	D	US-5,949,331	09-1999	Schofield et al.	340/461
	E	US-6,122,597	09-2000	Saneyoshi et al.	701/301
	F	US-5,530,420	06-1996	Tsuchiya et al.	340/435
	G	US-6,138,062	10-2000	Usami, Masayuki	701/23
	H	US-6,169,572	01-2001	Sogawa, Yoshiyuki	348/113
	I	US-6,370,261	04-2002	Hanawa, Keiji	382/104
	J	US-6,429,789	08-2002	Kiridena et al.	340/905
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